## Applicant(s)/Patent Under Application/Control No. Reexamination 10/719,017 FUJII, SHUJI **Notice of References Cited** Art Unit Examiner Page 1 of 1 2831 Jinhee J Lee **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 338/21 US-5,444,429 A 08-1995 Sakich et al. Α 218/9 US-5,091,616 A 02-1992 Ramos et al. В US-C D US-US-Ε F US-US-G Н US-US-US-US-Κ US-L М US-**FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) υ W

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